

STL33N60DM2

N-channel 600 V, 0.115 Ω typ., 21 A MDmesh™ DM2 Power MOSFET in a PowerFLAT™ 8x8 HV package

Datasheet - production data

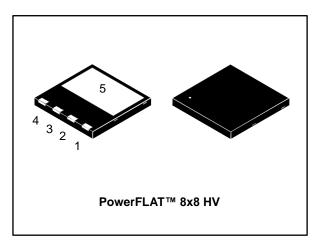
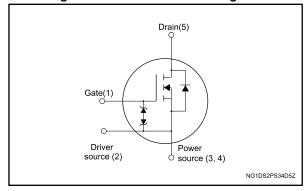


Figure 1: Internal schematic diagram



Features

Order code	V _{DS} @ T _{Jmax}	R _{DS(on)} max	I _D
STL33N60DM2	650 V	0.140 Ω	21 A

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

• Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmesh $^{\text{TM}}$ DM2 fast recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{\text{DS(on)}}$, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packaging
STL33N60DM2	33N60DM2	PowerFLAT™ 8x8 HV	Tape and reel

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STL33N60DM2 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	± 25	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	21	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C	15	Α
I _{DM} ⁽¹⁾ , ⁽²⁾	Drain current (pulsed)	84	Α
P _{TOT} (1)	Total dissipation at T _C = 25 °C	150	W
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_{j}max)$	4.5	Α
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	570	mJ
dv/dt (3)	Peak diode recovery voltage slope		V/ns
dv/dt (4)	MOSFET dv/dt ruggedness	50	V/ns
T _{stg}	Storage temperature range	55 to 150	°C
T _j	Operating junction temperature range		30

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	0.83	°C/W
R _{thj-amb} (1)	Thermal resistance junction-ambient max	45	°C/W

Notes:

 $[\]ensuremath{^{(1)}}$ The value is rated according to $R_{\ensuremath{^{thj\text{-}case}}}$ and limited by package.

 $[\]ensuremath{^{(2)}}\mbox{Pulse}$ width limited by safe operating area.

 $^{^{(3)}}I_{SD} \leq 21$ A, di/dt ≤ 900 A/µs, $V_{DS(peak)} < V_{(BR)DSS}, \ V_{DD} = 400$ V.

 $^{^{(4)}}V_{DS} \le 480 \text{ V}.$

 $^{^{(1)}\!}W$ hen mounted on FR-4 board of inch², 2oz Cu.

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4: On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0$, $I_D = 1$ mA	600			V
	Zoro goto voltago	$V_{GS} = 0, V_{DS} = 600 \text{ V}$			1	μΑ
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0,$ $V_{DS} = 600 \text{ V}, T_{C} = 125 \text{ °C}^{(1)}$			100	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0, V_{GS} = \pm 25 \text{ V}$			±10	μA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 10.5 A		0.115	0.140	Ω

Notes:

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1870	-	pF
C _{oss}	Output capacitance	$V_{DS} = 100 \text{ V, } f = 1 \text{ MHz,}$	-	87	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	2	-	pF
Coss eq. (1)	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$	1	157	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz, I _D =0 A	ı	4.5	-	Ω
Q_g	Total gate charge	V _{DD} = 480 V, I _D = 21 A	1	43	-	nC
Q_{gs}	Gate-source charge	V _{GS} = 10 V	-	9.8	-	nC
Q_{gd}	Gate-drain charge	(see Figure 15: "Gate charge test circuit")	-	21.4	-	nC

Notes:

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 $^{^{(1)}}$ Defined by design, not subject to production test.

 $^{^{(1)}}$ Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS-

Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 10.5 \text{ A}$	-	17	-	ns
t _r	Rise time	$R_G = 4.7 \Omega, V_{GS} = 10 V$	-	8	-	ns
t _{d(off)}	Turn-off delay time	(see Figure 14: "Switching times test circuit for resistive	-	62	-	ns
t _f	Fall time	load")	-	9	-	ns

Table 7: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} (1)	Source-drain current		ı		21	Α
I _{SDM} (1)(2)	Source-drain current (pulsed)		-		84	Α
V _{SD} ⁽³⁾	Forward on voltage	I _{SD} = 21 A, V _{GS} = 0	ı		1.6	V
t _{rr}	Reverse recovery time	04.4 45/45 400.4/	ı	120		ns
Q _{rr}	Reverse recovery charge	I _{SD} = 21 A, di/dt = 100 A/μs V _{DD} = 100 V (see Figure 16: " Test circuit for inductive load switching	1	0.53		μC
I _{RRM}	Reverse recovery current	and diode recovery times")	-	8.8		Α
t _{rr}	Reverse recovery time	I _{SD} = 21 A, di/dt = 100 A/μs	ı	316		ns
Q _{rr}	Reverse recovery charge	$V_{DD} = 100 \text{ V}, T_j = 150 \text{ °C}$ (see Figure 16: " Test circuit for	1	2.85		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	18		Α

Notes

Table 8: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS} = \pm 250 \mu\text{A}, I_{D} = 0 \text{A}$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



 $[\]ensuremath{^{(1)}}$ The value is rated according to $R_{thj\text{-case}}$ and limited by package.

⁽²⁾Pulse width limited by safe operating area

 $^{^{(3)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.2 Electrical characteristics (curves)

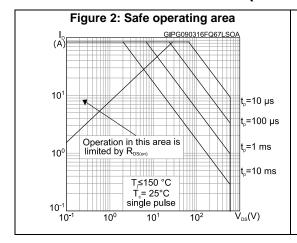


Figure 3: Thermal impedance

Zth Power FLAT 8x8 HV

0.2

0.1

0.05

Zth= K*RthJ-c

δ= tp/T

10²

10³

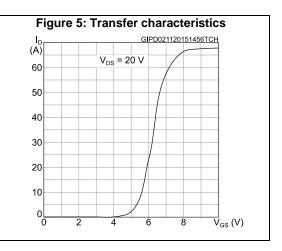
10³

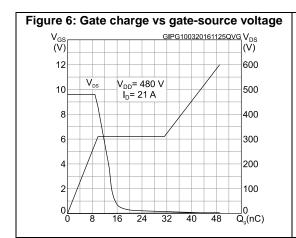
10³

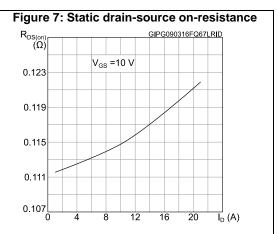
10³

10²

tp(s)







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STL33N60DM2 Electrical characteristics

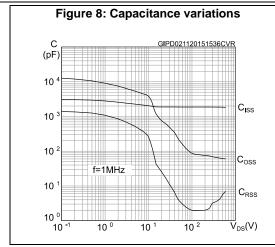


Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPD021120151654RON
(norm.)

2.2

1.8

1.4

1

0.6

0.2

-75

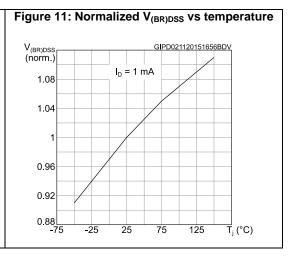
-25

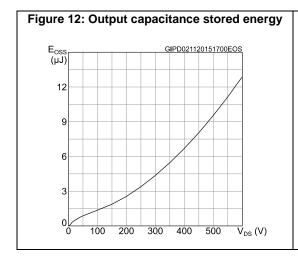
25

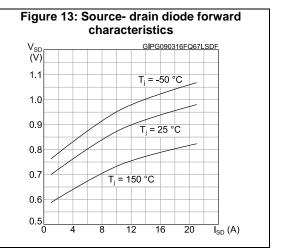
75

125

T_j (°C)

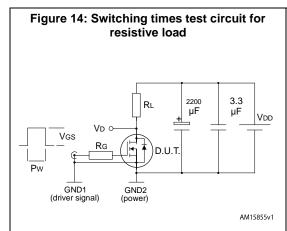


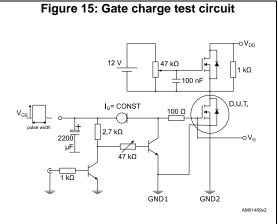


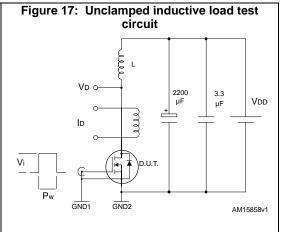


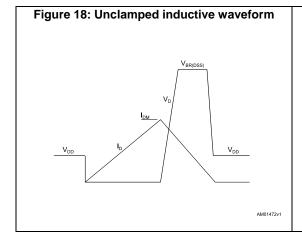
Test circuits STL33N60DM2

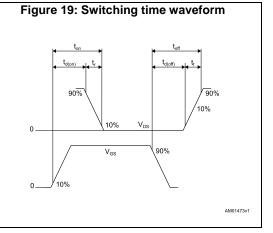
3 Test circuits











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4 Package mechanical data

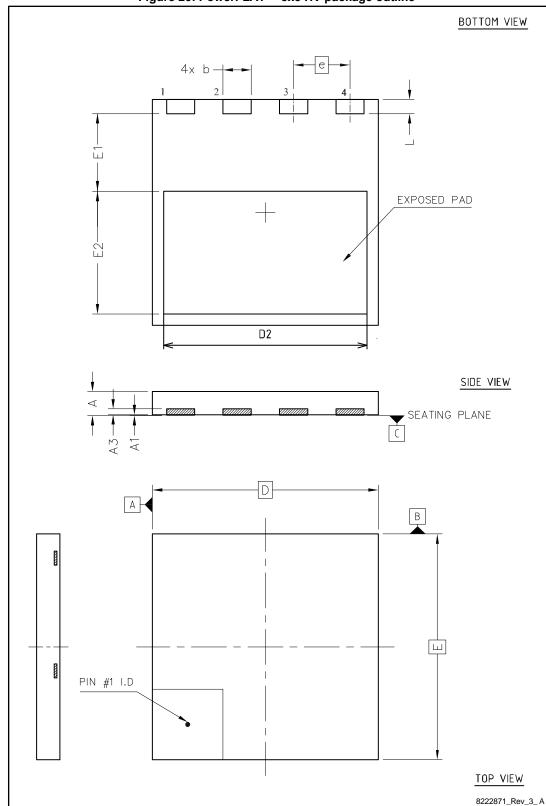
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



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4.1 PowerFLAT™ 8x8 HV package mechanical data

Figure 20: PowerFLAT™ 8x8 HV package outline

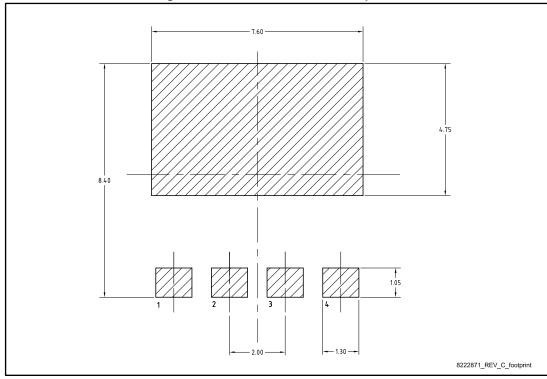


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Table 9: PowerFLAT™ 8x8 HV mechanical data

Dim.	mm				
Dilli.	Min.	Тур.	Max.		
А	0.75	0.85	0.95		
A1	0.00		0.05		
A3	0.10	0.20	0.30		
b	0.90	1.00	1.10		
D	7.90	8.00	8.10		
E	7.90	8.00	8.10		
D2	7.10	7.20	7.30		
E1	2.65	2.75	2.85		
E2	4.25	4.35	4.45		
е		2.00			
L	0.40	0.50	0.60		

Figure 21: PowerFLAT™ 8x8 HV footprint





All dimensions are in millimeters.



4.2 PowerFLAT™ 8x8 HV packing information

Figure 22: PowerFLAT™ 8x8 HV tape

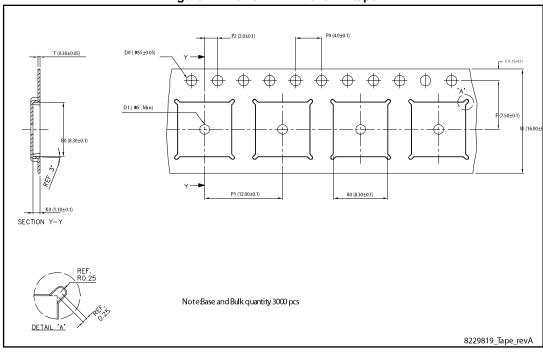
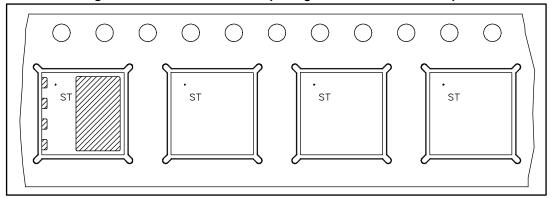


Figure 23: PowerFLAT™ 8x8 HV package orientation in carrier tape



4

2.0
R857.7
R13
R22
R13
R22
R13
R23
R13
R22
R13
R22
R13
R22
R13
R22
R330.0218
R13
R330.0218
R13
R330.0218
R330.0218

Figure 24: PowerFLAT™ 8x8 HV reel



Revision history STL33N60DM2

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
08-Aug-2014	1	First release.
		Updated title and internal schematic in cover page.
		Document status promoted from preliminary data to production data.
09-Mar-2016	2	Modified: Table 2: "Absolute maximum ratings", Table 4: "On /off states", Table 5: "Dynamic", Table 6: "Switching times" and Table 7: "Source drain diode"
		Added: Section 4.1: "Electrical characteristics (curves)"
		Updated: Section 6.1: "PowerFLAT™ 8x8 HV package mechanical data"
		Minor text changes

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